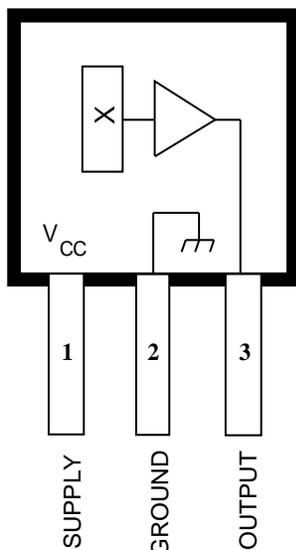


3515 AND 3516

RATIOMETRIC, LINEAR HALL-EFFECT SENSORS FOR HIGH-TEMPERATURE OPERATION



Dwg. PH-006

Pinning is shown viewed from branded side.

ABSOLUTE MAXIMUM RATINGS

| | |
|--|------------------------|
| Supply Voltage, V_{CC} | 8.0 V |
| Output Voltage, V_O | 8.0 V |
| Output Sink Current, I_O | 10 mA |
| Magnetic Flux Density, B | Unlimited |
| Package Power Dissipation, P_D | See Graph |
| Operating Temperature Range*, T_A Suffix E- | -40°C to +85°C |
| Suffix L- | -40°C to +150°C |
| Storage Temperature Range, T_S | -65°C to +170°C |

* Infrequent excursions permitted; see Applications Information.

The A3515-- and A3516-- are sensitive, temperature-stable linear Hall-effect sensors with greatly improved offset characteristics. Ratiometric, linear Hall-effect sensors provide a voltage output that is proportional to the applied magnetic field and have a quiescent output voltage that is approximately 50% of the supply voltage. These magnetic sensors are ideal for use in linear and rotary position sensing systems in the harsh environments of automotive and industrial applications over extended temperatures to -40°C and +150°C. The A3515-- features an output sensitivity of 5 mV/G while the A3516-- has an output sensitivity of 2.5 mV/G. See the Magnetic Characteristics table for complete, individual device parametrics.

Each BiCMOS monolithic circuit integrates a Hall element, improved temperature-compensating circuitry to reduce the intrinsic sensitivity drift of the Hall element, a small-signal high-gain amplifier, and a rail-to-rail low-impedance output stage.

A proprietary dynamic offset cancelation technique, with an internal high-frequency clock, reduces the residual offset voltage, which is normally caused by device overmolding, temperature dependancies, and thermal stress. This technique produces devices that have an extremely stable quiescent output voltage, are immune to mechanical stress, and have precise recoverability after temperature cycling. Many problems normally associated with low-level analog signals are minimized by having the Hall element and amplifier in a single chip. Output precision is obtained by internal gain and offset trim adjustments during the manufacturing process.

These devices are supplied in a 3-pin mini-SIP "U" package or a 3-pin ultra-mini-SIP "UA" package.

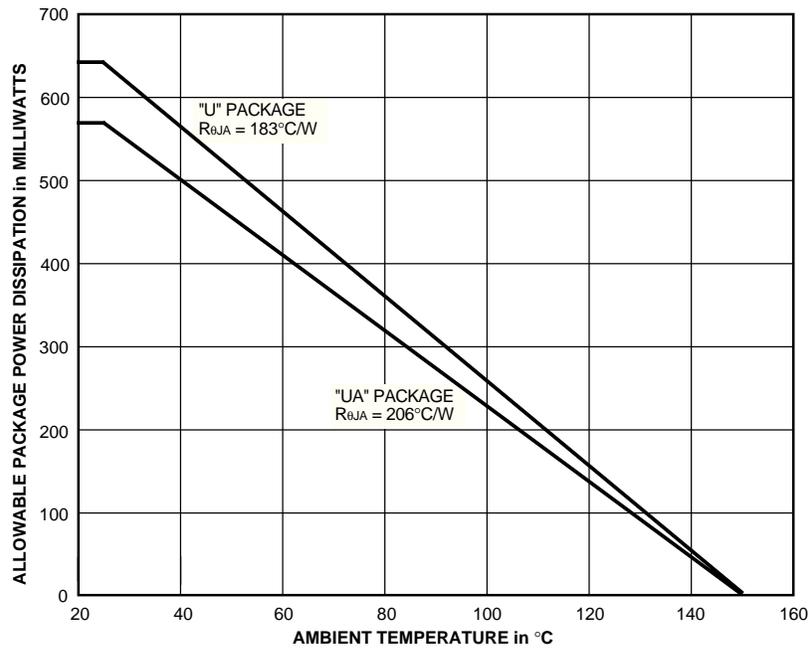
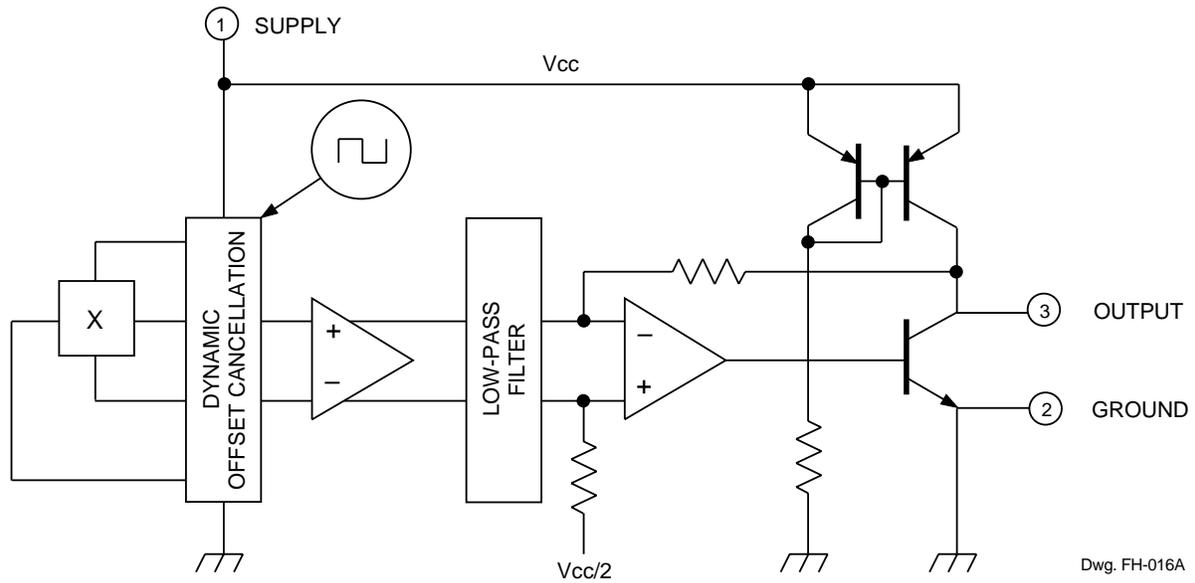
FEATURES

- Temperature-Stable Quiescent Output Voltage
- Precise Recoverability After Temperature Cycling
- Output Voltage Proportional to Applied Magnetic Field
- Ratiometric Rail-to-Rail Output
- Improved Sensitivity
- 4.5 V to 5.5 V Operation
- Immune to Mechanical Stress
- Small Package Size
- Solid-State Reliability

Always order by complete part number, e.g., **A3515LUA**.

3515 AND 3516 RATIOMETRIC, LINEAR HALL-EFFECT SENSORS

FUNCTIONAL BLOCK DIAGRAM



**3515 AND 3516
RATIOMETRIC,
LINEAR
HALL-EFFECT SENSORS**

ELECTRICAL CHARACTERISTICS over operating temperature range, at $V_{CC} = 5\text{ V}$ (unless otherwise noted).

| Characteristic | Symbol | Test Conditions | Limits | | | |
|------------------------------|-----------|---|--------|-------|-------|---------------|
| | | | Min. | Typ. | Max. | Units |
| Supply Voltage | V_{CC} | Operating | 4.5 | 5.0 | 5.5 | V |
| Supply Current | I_{CC} | $B = 0, V_{CC} = 6\text{ V}, I_O = 0$ | – | 7.2 | 10 | mA |
| Quiescent Voltage Output | V_{OQ} | $B = 0, I_O = 1\text{ mA}, T_A = 25^\circ\text{C}$ | 2.425 | 2.500 | 2.575 | V |
| Output Voltage | V_{OH} | $B = +X^*, I_O = 1\text{ mA}$ | – | 4.7 | – | V |
| | V_{OL} | $B = -X^*, I_O = -1\text{ mA}$ | – | 0.2 | – | V |
| Output Source Current Limit | I_{OLM} | $B = -X^*, V_O = 0$ | -1.0 | -1.5 | – | mA |
| Bandwidth (-3 dB) | BW | | – | 30 | – | kHz |
| Clock Frequency | f_C | | – | 170 | – | kHz |
| Output Resistance | r_O | $I_O \leq -2\text{ mA}$ | – | 1.0 | – | Ω |
| Wide-Band Output Noise (rms) | e_o | $B = 0, BW = 10\text{ Hz to }10\text{ kHz}, I_O \leq -1\text{ mA}, C_O = 100\text{ pF}$ | – | 400 | – | μV |

NOTE 1 – Typical data is at $T_A = 25^\circ\text{C}$ and is for design information only.

NOTE 2 – Negative current is defined as coming out of (sourcing) the output.

* This test requires positive and negative fields sufficient to swing the output driver between fully OFF and saturated (ON), respectively. It is NOT intended to indicate a range of linear operation.

3515 AND 3516 RATIOMETRIC, LINEAR HALL-EFFECT SENSORS

MAGNETIC CHARACTERISTICS over operating temperature range, at $V_{CC} = 5\text{ V}$, $I_O = -1\text{ mA}$ (unless otherwise noted).

| Characteristic* | Part Numbers | | | | | | | | | | | | Units |
|---|--------------|------|----------|------------|------|----------|------------|------|----------|------------|------|----------|-------|
| | A3515EU/UA | | | A3515LU/UA | | | A3516EU/UA | | | A3516LU/UA | | | |
| | Min. | Typ. | Max. | Min. | Typ. | Max. | Min. | Typ. | Max. | Min. | Typ. | Max. | |
| Operating Temp. Range, T_A | -40 | - | +85 | -40 | - | +150 | -40 | - | +85 | -40 | - | +150 | °C |
| Sensitivity at $T_A = 25^\circ\text{C}$ | 4.50 | 5.00 | 5.50 | 4.50 | 5.00 | 5.50 | 2.25 | 2.50 | 2.75 | 2.25 | 2.50 | 2.75 | mV/G |
| $\Delta\text{Sens}_{(\Delta T)}$ at $T_A = \text{Max.}$ | -2.5 | 2.5 | 7.5 | -2.5 | 2.5 | 7.5 | -2.5 | 2.5 | 7.5 | -2.5 | 2.5 | 7.5 | % |
| $\Delta\text{Sens}_{(\Delta T)}$ at $T_A = \text{Min.}$ | -9.0 | -1.3 | 1.0 | -9.0 | -1.3 | 1.0 | -9.0 | -1.3 | 1.0 | -9.0 | -1.3 | 1.0 | % |
| $\Delta V_{OQ(\Delta T)}^\dagger$ | - | - | ± 10 | - | - | ± 10 | - | - | ± 10 | - | - | ± 10 | G |
| Ratiometry, $\Delta V_{OQ(\Delta V)}$ | - | 100 | - | - | 100 | - | - | 100 | - | - | 100 | - | % |
| Ratiometry, $\Delta\text{Sens}_{(\Delta V)}$ | - | 100 | - | - | 100 | - | - | 100 | - | - | 100 | - | % |
| Positive Linearity, Lin+ | - | 100 | - | - | 100 | - | - | 100 | - | - | 100 | - | % |
| Negative Linearity, Lin- | - | 100 | - | - | 100 | - | - | 100 | - | - | 100 | - | % |
| Symmetry | - | 100 | - | - | 100 | - | - | 100 | - | - | 100 | - | % |

NOTE 1 – Magnetic flux density is measured at most sensitive area of device located 0.015" (0.38 mm) below the branded face of the "U" package; 0.018" (0.46 mm) below the branded face of the "UA" package.

NOTE 2 – 10 G = 1 mT, exactly.

NOTE 3 – Except for $\Delta\text{Sens}_{(\Delta T)}$, typical data is at $T_A = 25^\circ\text{C}$ and is for design information only.

* See Characteristics Definitions for test conditions.

† This calculation (formula 1, next page) yields the device's equivalent accuracy, over the operating temperature range, in gauss.

3515 AND 3516 RATIOMETRIC, LINEAR HALL-EFFECT SENSORS

CHARACTERISTICS DEFINITIONS

Quiescent Voltage Output. In the quiescent state (no magnetic field), the output is ideally equal to one-half of the supply voltage over the operating voltage and temperature range ($V_{OQ} \approx V_{CC}/2$). Due to internal component tolerances and thermal considerations, there is a tolerance on the quiescent voltage output and on the quiescent voltage output as a function of supply voltage and ambient temperature. For purposes of specification, the quiescent voltage output as a function of temperature is defined as

$$\Delta V_{OQ(\Delta T)} = \frac{V_{OQ(TA)} - V_{OQ(25^\circ C)}}{Sens_{(25^\circ C)}} \quad (1)$$

This calculation yields the device's equivalent accuracy, over the operating temperature range, in gauss.

Sensitivity. The presence of a south-pole magnetic field perpendicular to the package face (the branded surface) will increase the output voltage from its quiescent value toward the supply voltage rail by an amount proportional to the magnetic field applied. Conversely, the application of a north pole will decrease the output voltage from its quiescent value. This proportionality is specified as the sensitivity of the device and is defined as

$$Sens = \frac{V_{O(500G)} - V_{O(-500G)}}{1000 \text{ G}} \quad (2)$$

The stability of sensitivity as a function of temperature is defined as

$$\Delta Sens_{(\Delta T)} = \frac{Sens_{(TA)} - Sens_{(25^\circ C)}}{Sens_{(25^\circ C)}} \times 100\% \quad (3)$$

Ratiometry. The A3515xU, A3515xUA, A3516xU, and A3516xUA feature a ratiometric output. The quiescent voltage output and sensitivity are proportional to the supply voltage (ratiometric).

The per cent ratiometric change in the quiescent voltage output is defined as

$$\Delta V_{OQ(\Delta V)} = \frac{V_{OQ(VCC)} / V_{OQ(5V)}}{V_{CC} / 5 \text{ V}} \times 100\% \quad (4)$$

and the per cent ratiometric change in sensitivity is defined as

$$\Delta Sens_{(\Delta V)} = \frac{Sens_{(VCC)} / Sens_{(5V)}}{V_{CC} / 5 \text{ V}} \times 100\% \quad (5)$$

Linearity and Symmetry. The on-chip output stage is designed to provide a linear output to within 500 mV of either rail with a supply voltage of 5 V. This is equivalent to approximately ± 800 gauss of ambient field. Although application of stronger magnetic fields will not damage these devices, it will force the output into a non-linear region. Linearity in per cent is measured and defined as

$$Lin+ = \frac{V_{O(500G)} - V_{OQ}}{2 (V_{O(250G)} - V_{OQ})} \times 100\% \quad (6)$$

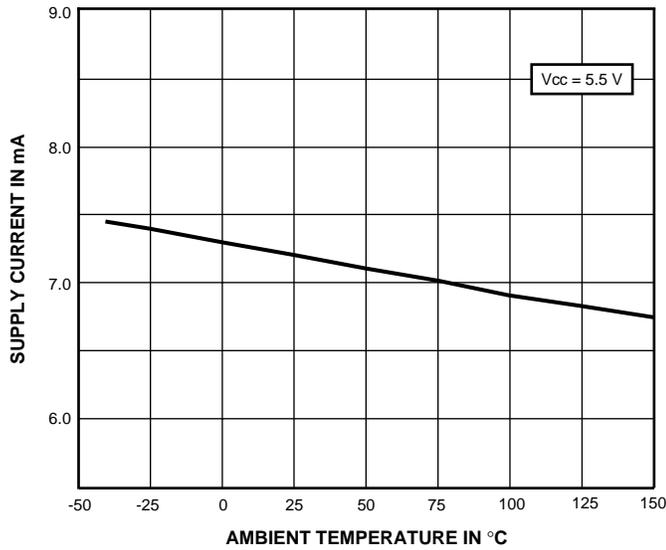
$$Lin- = \frac{V_{O(-500G)} - V_{OQ}}{2 (V_{O(-250G)} - V_{OQ})} \times 100\% \quad (7)$$

and output symmetry as

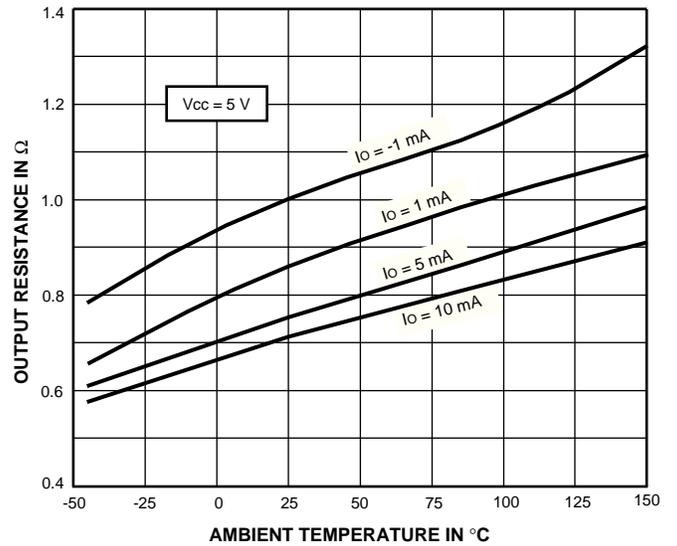
$$Sym = \frac{V_{O(500G)} - V_{OQ}}{V_{OQ} - V_{O(-500G)}} \times 100\% \quad (8)$$

3515 AND 3516 RATIOMETRIC, LINEAR HALL-EFFECT SENSORS

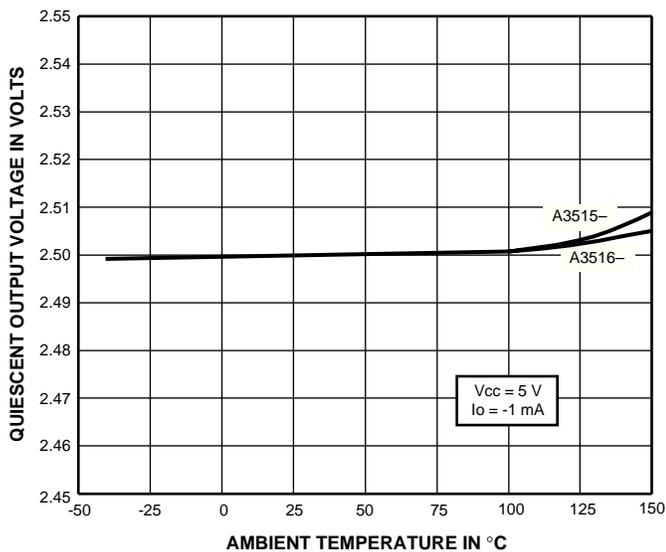
TYPICAL CHARACTERISTICS



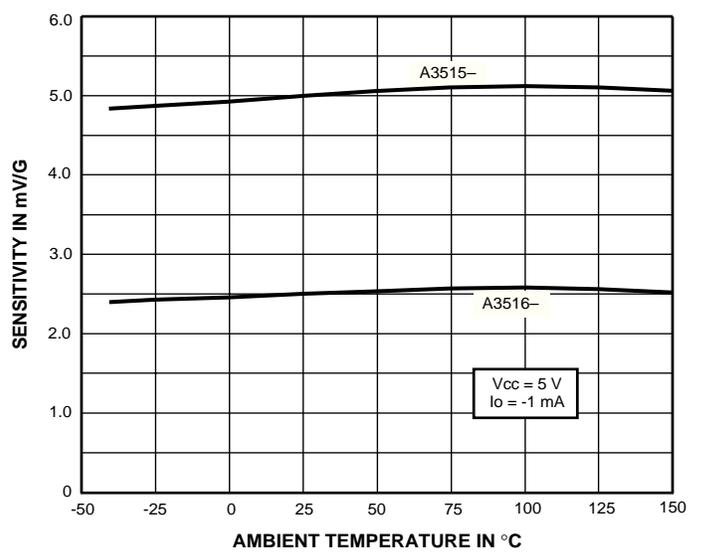
Dwg. GH-039-2



Dwg. GH-060-1



Dwg. GH-067



Dwg. GH-066

**3515 AND 3516
RATIOMETRIC,
LINEAR
HALL-EFFECT SENSORS**

CRITERIA FOR DEVICE QUALIFICATION

All Allegro sensors are subjected to stringent qualification requirements prior to being released to production. To become qualified, except for the destructive ESD tests, no failures are permitted.

| Qualification Test | Test Method and Test Conditions | Test Length | Samples | Comments |
|---|--|---------------------|----------------|-------------------------------------|
| Temperature Humidity Bias Life | JESD22-A101 $T_A = 85^{\circ}\text{C}$, RH = 85% | 1000 hrs | 77 | Device biased for minimum power |
| Bias Life | JESD22-A108 $T_A = 150^{\circ}\text{C}$, $T_J = 165^{\circ}\text{C}$ | 1000 hrs | 77 | |
| (Surge Operating Life) | JESD22-A108 $T_A = 175^{\circ}\text{C}$, $T_J = 190^{\circ}\text{C}$ | 168 hrs | 77 | |
| Autoclave, Unbiased | JESD22-A102 $T_A = 121^{\circ}\text{C}$, 15 psig | 96 hrs | 77 | |
| High-Temperature (Bake) Storage Life | JESD22-A103 $T_A = 170^{\circ}\text{C}$ | 1000 hrs | 77 | |
| Temperature Cycle | JESD22-A104 | 1000 cycles | 77 | |
| ESD, Human Body Model | CDF-AEC-Q100-002 | Pre/Post Reading | 3 per test | Test to failure All leads > 3 kV |

3515 AND 3516 RATIOMETRIC, LINEAR HALL-EFFECT SENSORS

APPLICATIONS INFORMATION

Calibrated linear Hall devices, which can be used to determine the actual flux density presented to the sensor in a particular application, are available.

For safe, reliable operation, the output should not be pulled above the supply voltage or pulled below the device ground.

For optimum performance, a 0.1 μF capacitor between the supply and ground, and a 100 pF capacitor between the output and ground, should be added.

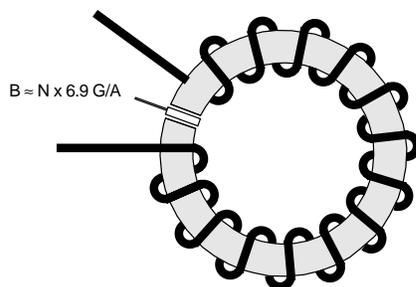
The ratiometric feature is especially valuable when these devices are used with an analog-to-digital converter. A/D converters typically derive their LSB step size by ratioing off a reference voltage line. If the reference voltage varies, the LSB will vary proportionally. This is a major error source in many sensing systems. The A3515xU, A3515xUA, A3516xU, and A3516xUA can eliminate this source of error by their ratiometric operation. Because their gain and offsets are proportional to the supply voltage, if they are powered from the A/D reference voltage, the sensor output voltage will track changes in the LSB value.

These devices can withstand infrequent temperature excursions, beyond the Absolute Maximum Ratings, to $T_A = 170^\circ\text{C}$ provided the junction temperature, T_J , does not exceed 200°C .

Extensive applications information on Hall-effect sensors and magnets is also available in the "Hall-Effect IC Applications Guide", which can be found in the latest issue of the *Allegro MicroSystems Electronic Data Book*, AMS-702 or *Application Note 27701*, or at

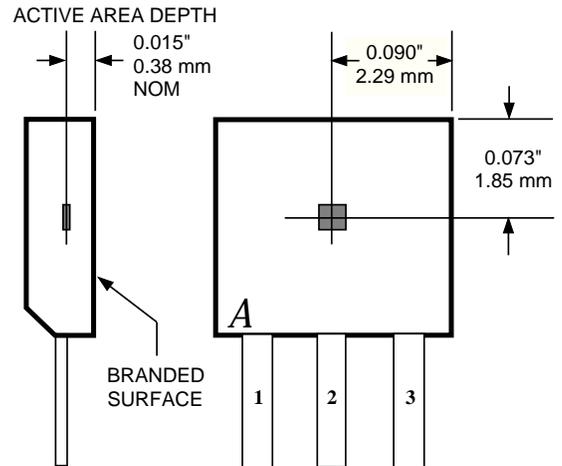
www.allegromicro.com

TYPICAL CURRENT-SENSING APPLICATION



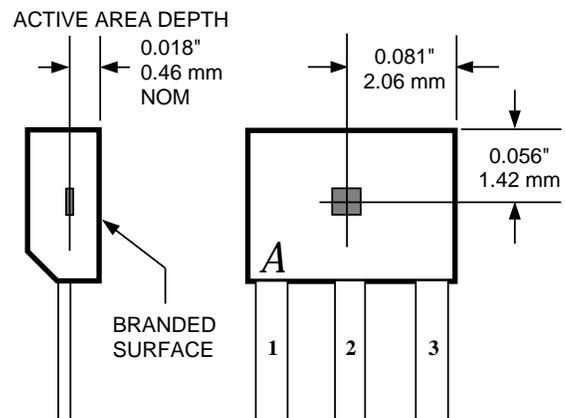
Dwg. AH-005A

SENSOR LOCATION SUFFIX "U"



Dwg. MH-002-10A

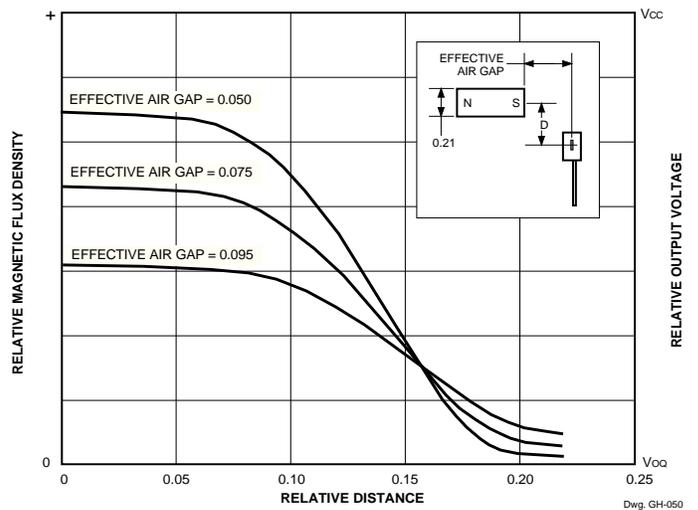
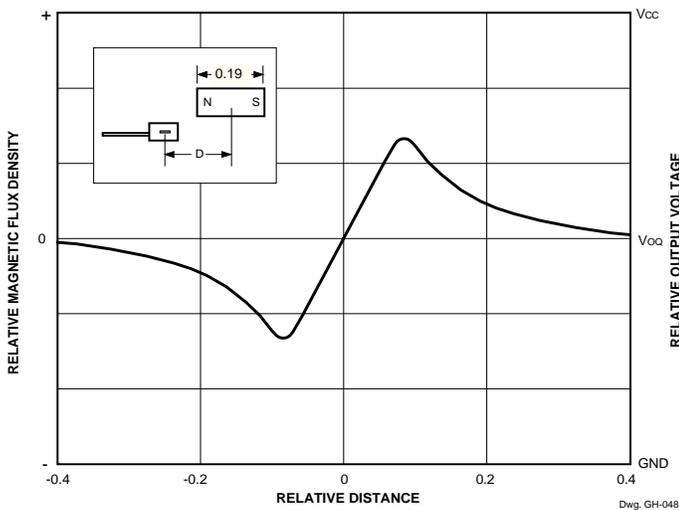
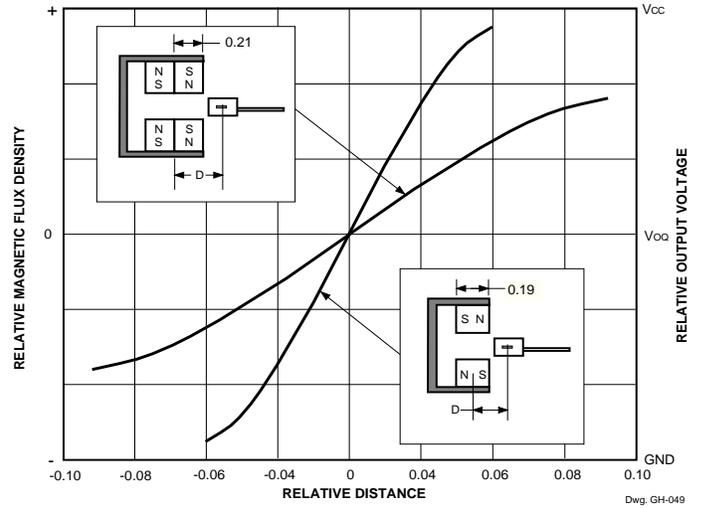
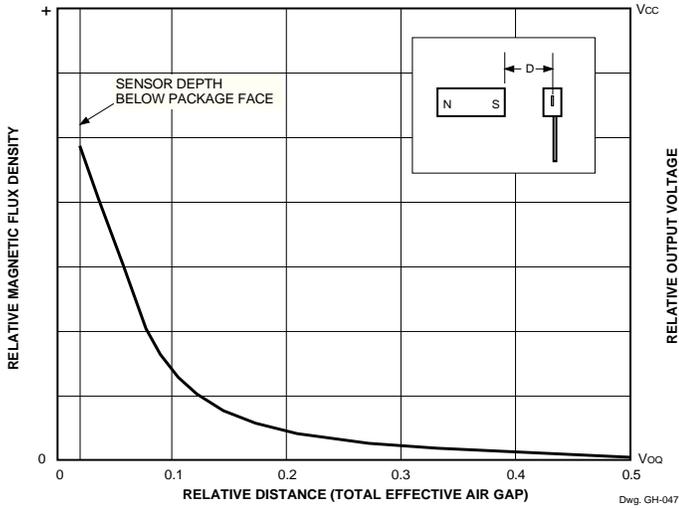
SUFFIX "UA"



Dwg. MH-011-7

3515 AND 3516 RATIOMETRIC, LINEAR HALL-EFFECT SENSORS

TYPICAL POSITION-SENSING APPLICATIONS (Alnico 8, dimensions in inches)

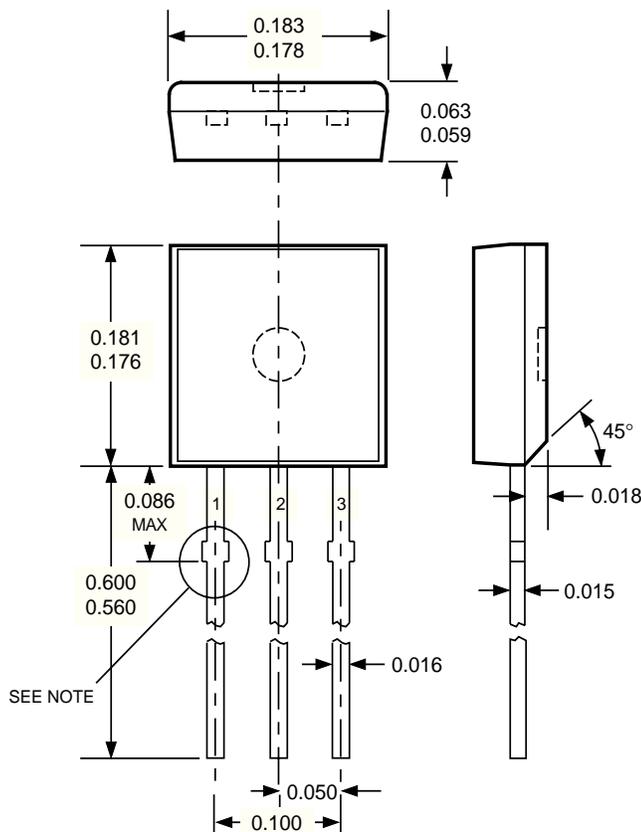


3515 AND 3516 RATIOMETRIC, LINEAR HALL-EFFECT SENSORS

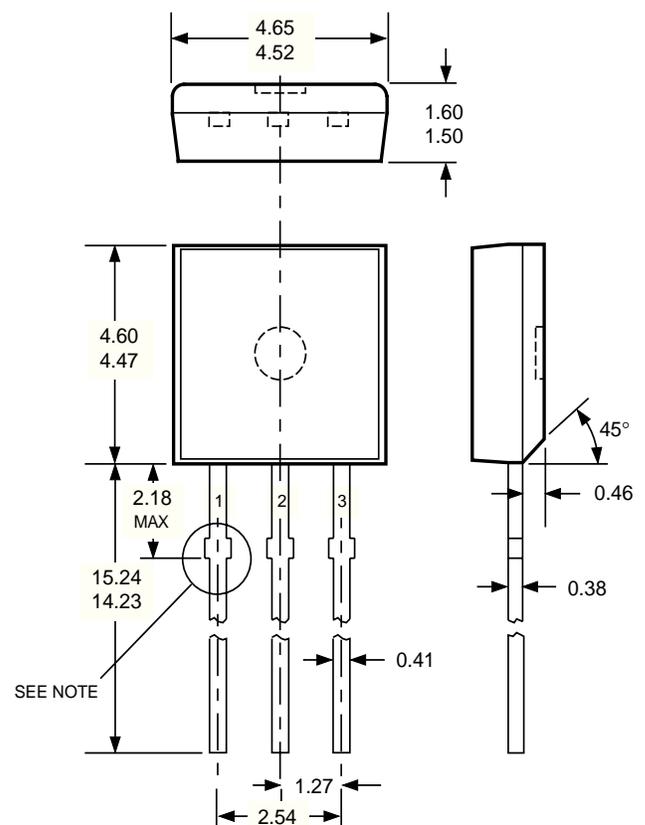
A3515xU and A3516xU

Dimensions in Inches
(controlling dimensions)

Dimensions in Millimeters
(for reference only)



Dwg. MH-003D in



Dwg. MH-003D mm

**Devices in the 'U' package are
NOT RECOMMENDED FOR NEW DESIGN**

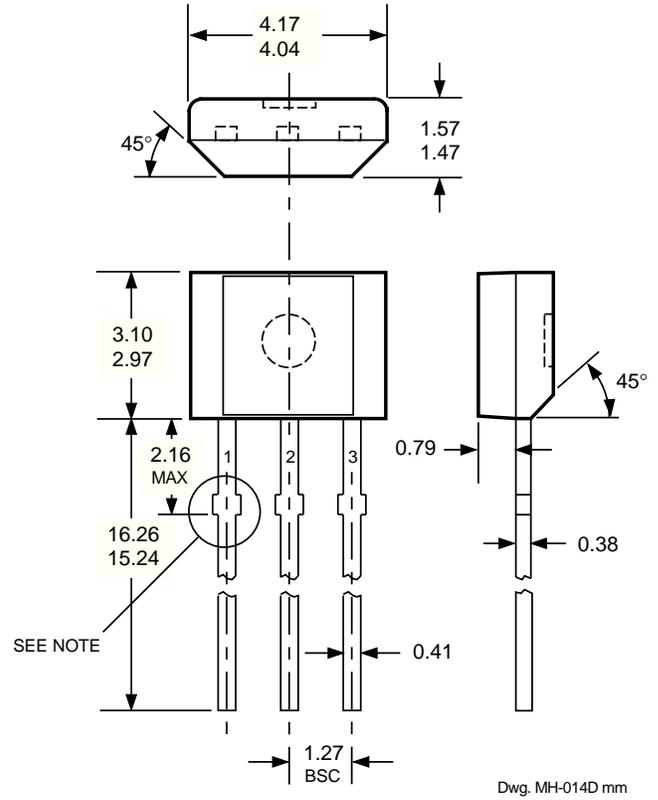
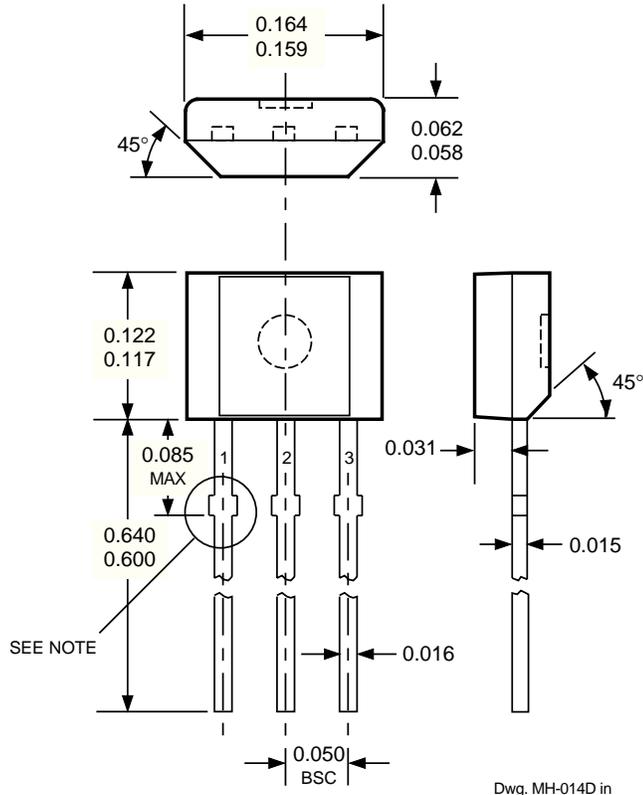
- NOTES:
1. Tolerances on package height and width represent allowable mold offsets. Dimensions given are measured at the widest point (parting line).
 2. Exact body and lead configuration at vendor's option within limits shown.
 3. Height does not include mold gate flash.
 4. Recommended minimum PWB hole diameter to clear transition area is 0.035" (0.89 mm).
 5. Where no tolerance is specified, dimension is nominal.

3515 AND 3516 RATIOMETRIC, LINEAR HALL-EFFECT SENSORS

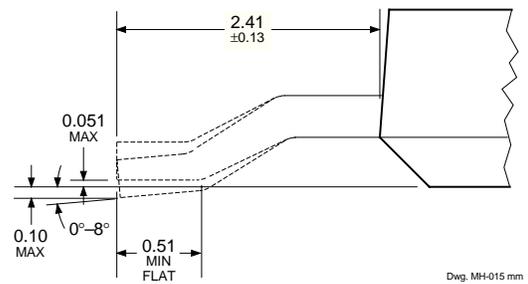
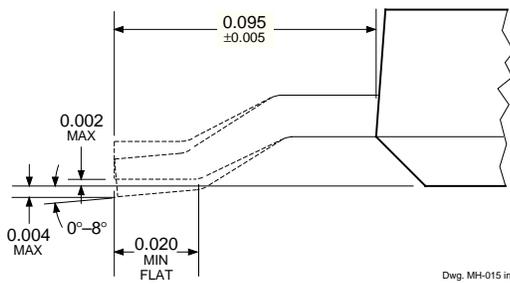
A3515xUA and A3516xUA

Dimensions in Inches
(controlling dimensions)

Dimensions in Millimeters
(for reference only)



SURFACE-MOUNT LEAD FORM (Suffix '-TL,')



- NOTES:
1. Tolerances on package height and width represent allowable mold offsets. Dimensions given are measured at the widest point (parting line).
 2. Exact body and lead configuration at vendor's option within limits shown.
 3. Height does not include mold gate flash.
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